

## CD4024BC 7-Stage Ripple Carry Binary Counter

### General Description

The CD4024BC is a 7-stage ripple-carry binary counter. Buffered outputs are externally available from stages 1 through 7. The counter is reset to its logical "0" stage by a logical "1" on the reset input. The counter is advanced one count on the negative transition of each clock pulse.

### Features

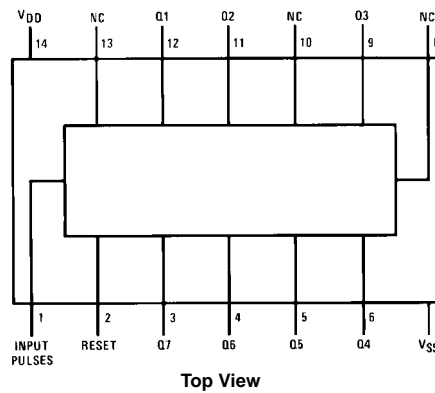
- Wide supply voltage range: 3.0V to 15V
- High noise immunity:  $0.45 V_{DD}$  (typ.)
- Low power TTL compatibility: Fan out of 2 driving 74L or 1 driving 74LS
- High speed: 12 MHz (typ.)  
input pulse rate  $V_{DD} - V_{SS} = 10V$
- Fully static operation

### Ordering Code:

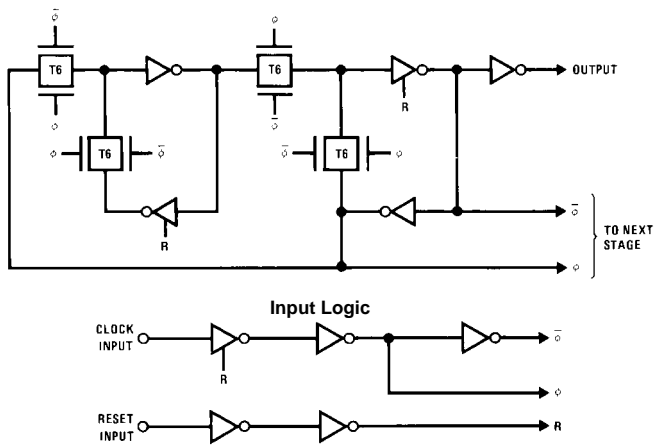
Order Number	Package Number	Package Description
CD4024BCM	M14A	14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow
CD4024BCN	N14A	14-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide

Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

### Connection Diagram

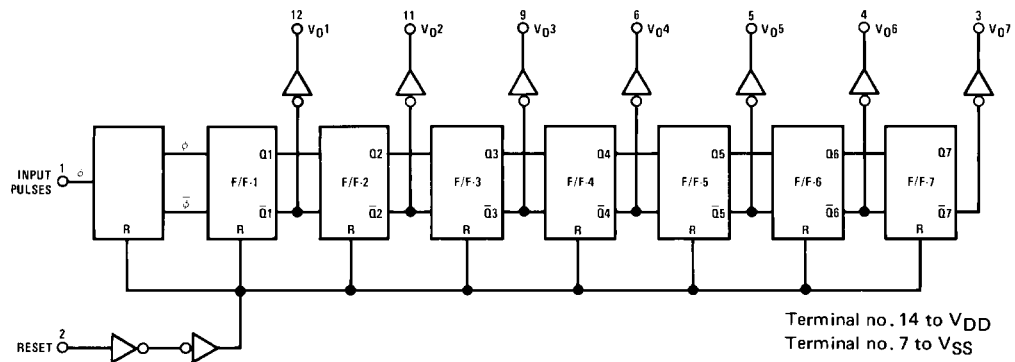


Logic Diagrams



Flip-flop logic (1 of 7 identical stages).

Block Diagram



**Absolute Maximum Ratings**(Note 1)

(Note 2)

DC Supply Voltage ( $V_{DD}$ )	-0.5 to +18 $V_{DC}$
Input Voltage ( $V_{IN}$ )	-0.5 to $V_{DD} + 0.5 V_{DC}$
Storage Temperature Range ( $T_S$ )	-65°C to +150°C
Power Dissipation ( $P_D$ )	
Dual-In-Line	700 mW
Small Outline	500 mW
Lead Temperature	
(Soldering, 10 seconds) ( $T_L$ )	260°C

**Recommended Operating Conditions** (Note 1)

DC Supply Voltage ( $V_{DD}$ )	+3 to +15 $V_{DC}$
Input Voltage ( $V_{IN}$ )	0 to $V_{DD} V_{DC}$
Operating Temperature Range ( $T_A$ )	-55°C to +125°C

**Note 1:** "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed, they are not meant to imply that the devices should be operated at these limits. The table of "Recommended Operating Conditions" and "Electrical Characteristics" provides conditions for actual device operation.

**Note 2:**  $V_{SS} = 0V$  unless otherwise specified.

**DC Electrical Characteristics** (Note 2)

Symbol	Parameter	Conditions	-55°C		+25°C			+125°C		Units
			Min	Max	Min	Typ	Max	Min	Max	
$I_{DD}$	Quiescent Device Current	$V_{DD} = 5V$ $V_{DD} = 10V$ $V_{DD} = 15V$		5 10 20		0.3 0.5 0.7	5 10 20	150 300 600	$\mu A$	
$V_{OL}$	LOW Level Output Voltage	$ I_O  < 1 \mu A$ $V_{DD} = 5V$ $V_{DD} = 10V$ $V_{DD} = 15V$		0.05 0.05 0.05		0 0 0	0.05 0.05 0.05	0.05 0.05 0.05	V	
$V_{OH}$	HIGH Level Output Voltage	$ I_O  < 1 \mu A$ $V_{DD} = 5V$ $V_{DD} = 10V$ $V_{DD} = 15V$	4.95 9.95 14.95		4.95 9.95 14.95	5 10 15		4.95 9.95 14.95	V	
$V_{IL}$	LOW Level Input Voltage	$ I_O  < 1 \mu A$ $V_{DD} = 5V, V_O = 0.5V$ or 4.5V $V_{DD} = 10V, V_O = 1.0V$ or 9.0V $V_{DD} = 15V, V_O = 1.5V$ or 13.5V		1.5 3.0 4.0		2 4 6	1.5 3.0 4.0	1.5 3.0 4.0	V	
$V_{IH}$	HIGH Level Input Voltage	$ I_O  < 1 \mu A$ $V_{DD} = 5V, V_O = 0.5V$ or 4.5V $V_{DD} = 10V, V_O = 1.0V$ or 9.0V $V_{DD} = 15V, V_O = 1.5V$ or 13.5V	3.5 7.0 11.0		3.5 7.0 11.0	3 6 9		3.5 7.0 11.0	V	
$I_{OL}$	LOW Level Output Current (Note 3)	$V_{DD} = 5V, V_O = 0.4V$ $V_{DD} = 10V, V_O = 0.5V$ $V_{DD} = 15V, V_O = 1.5V$	0.64 1.6 4.2		0.51 1.3 3.4	0.88 2.25 8.8		0.36 0.9 2.4	mA	
$I_{OH}$	HIGH Level Output Current (Note 3)	$V_{DD} = 5V, V_O = 4.6V$ $V_{DD} = 10V, V_O = 9.5V$ $V_{DD} = 15V, V_O = 13.5V$	-0.64 -1.6 -4.2		-0.51 -1.3 -3.4	-0.88 -2.25 -8.8		-0.36 -0.9 -2.4	mA	
$I_{IN}$	Input Current	$V_{DD} = 15V, V_{IN} = 0V$ $V_{DD} = 15V, V_{IN} = 15V$		-0.1 0.1		$-10^{-5}$ $10^{-5}$	-0.1 0.1	-1.0 1.0	$\mu A$	

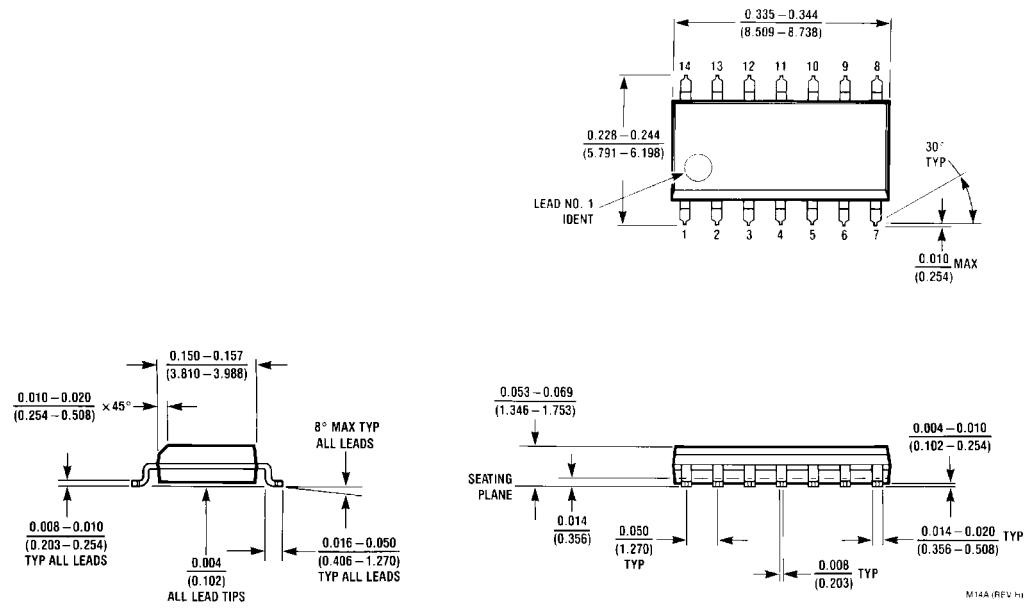
**Note 3:**  $I_{OH}$  and  $I_{OL}$  are tested one output at a time.

**AC Electrical Characteristics** (Note 4) $T_A = 25^\circ\text{C}$ ,  $C_L = 50\text{ pF}$ ,  $R_L = 200\text{ k}$ ,  $t_r$  and  $t_f = 20\text{ ns}$  unless otherwise specified

Symbol	Parameter	Conditions	Min	Typ	Max	Units
$t_{PHL}$ , $t_{PLH}$	Propagation Delay Time to Q1 Output	$V_{DD} = 5V$ $V_{DD} = 10V$ $V_{DD} = 15V$		185 85 70	350 125 100	ns
$t_{THL}$ , $t_{TLH}$	Transition Time	$V_{DD} = 5V$ $V_{DD} = 10V$ $V_{DD} = 15V$		100 50 40	200 100 80	ns
$t_{WL}$ , $t_{WH}$	Minimum Input Pulse Width	$V_{DD} = 5V$ $V_{DD} = 10V$ $V_{DD} = 15V$		75 40 35	200 110 90	ns
$t_{RCL}$ , $t_{FCL}$	Input Rise and Fall Time	$V_{DD} = 5V$ $V_{DD} = 10V$ $V_{DD} = 15V$			15 10 8	$\mu\text{s}$
$f_{CL}$	Maximum Input Pulse Frequency	$V_{DD} = 5V$ $V_{DD} = 10V$ $V_{DD} = 15V$	1.5 4 5	5 12 15		MHz
$t_{PHL}$	Reset Propagation Delay Time	$V_{DD} = 5V$ $V_{DD} = 10V$ $V_{DD} = 15V$		185 85 70	350 125 100	ns
$t_{WH}$	Reset Minimum Pulse Width	$V_{DD} = 5V$ $V_{DD} = 10V$ $V_{DD} = 15V$		185 85 70	350 125 100	ns
$C_{IN}$	Input Capacitance (Note 5)	Any Input		5	7.5	pF

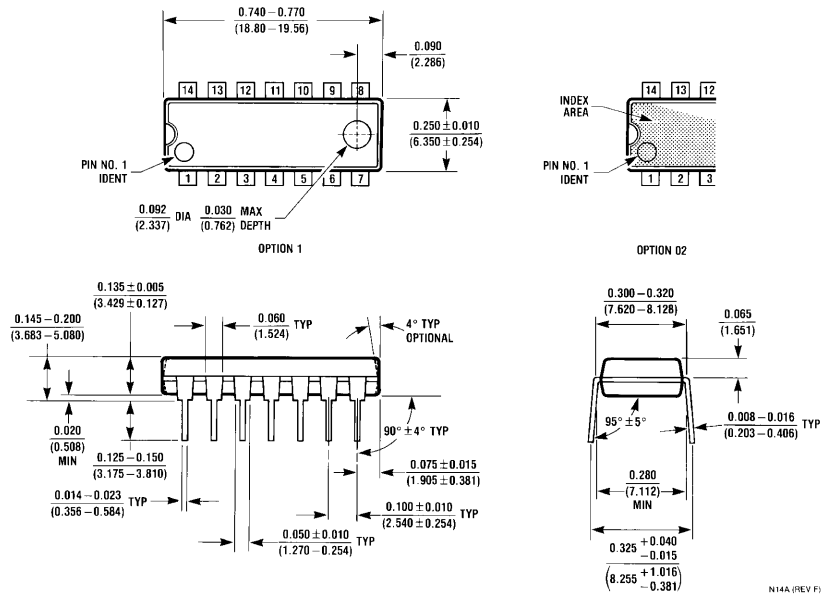
**Note 4:** AC Parameters are guaranteed by DC correlated testing.**Note 5:** Capacitance is guaranteed by periodic testing.

**Physical Dimensions** inches (millimeters) unless otherwise noted



**14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow Package Number M14A**

**Physical Dimensions** inches (millimeters) unless otherwise noted (Continued)



**14-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide  
Package Number N14A**

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